Search Notes

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Application/Control	No.

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HENOK G HEYI

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	SEARCHED		
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SEARCH NOTES				
Search Notes	Date	Examiner		
Searched EAST and consulted Primary Tan Dinh. Some of the subclasses searched are 369/30.03, 30.05, 47.12, 47.13, 83 and 84 (text search only - please see search history printout).	05/02/2008	Henok Heyi		
Updated search.	12/24/2008	Henok Heyi		
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	INTERFERENCE SEA	RCH	
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